

TEST REPORT

of

FCC MPE REQUIREMENT

Product : Semiconductor RFID

Brand Name: Brillian

Model: MF Reader

Model Difference: N/A

Applicant: Brillian Network & Automation Integrated System Co.,Ltd

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Test Performed by:

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Report No.: ISL-23LR0063FMPE
Issue Date :2023/05/17



Test results given in this report apply only to the specific sample(s) tested and are traceable to national or international standard through calibration of the equipment and evaluating measurement uncertainty herein.

The uncertainty of the measurement does not include in consideration of the test result unless the customer required the determination of uncertainty via the agreement, regulation or standard document specification.

This test report shall not be reproduced except in full, without the written approval of International Standards Laboratory Corp.

VERIFICATION OF COMPLIANCE

Applicant: Brillian Network & Automation Integrated System Co.,Ltd
Product Description: Semiconductor RFID
Brand Name: Brillian
Model No.: MF Reader
Model Difference: N/A
Date of test: 2023/05/15 ~ 2023/05/17
Date of EUT Received: 2022/05/15

We hereby certify that:

All the tests in this report have been performed and recorded in accordance with the standards described above and performed by an independent electromagnetic compatibility consultant, International Standards Laboratory Corp.

The test results contained in this report accurately represent the measurements of the characteristics and the energy generated by sample equipment under test at the time of the test. The sample equipment tested as described in this report is in compliance with the limits of above standards.

Test By:		Date:	2023/05/17
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Table of Contents

1. Description of Equipment under Test (EUT).....	4
2. Test Configuration	5
2.1 EUT Configuration	5
2.2 EUT Exercise	5
2.3 Measurement Equipment Used:	5
2.4 Configuration of Tested System	6
2.5 Description of Test Modes.....	7
2.6 Test Procedure.....	7
3. Summary of Test Results	8
4. Standard Applicable.....	9
5. Evaluation Result:	11
PHOTOGRAPHS OF SET UP	12

1. Description of Equipment under Test (EUT)

General:

Product Name:	Semiconductor RFID
Brand Name:	Brillian
Model Name:	MF Reader
Model Difference:	N/A
Power Supply:	24Vdc
Frequency Range:	134kHz
Modulation Type	FSK

	Antenna Type	Brand	Model	Frequency Range	Connector Type
1	Dipole Antenna	Brillian	SLC-1500	134kHz	PH

2. Test Configuration

2.1 EUT Configuration

The EUT configuration for testing is installed on RF field strength measurement to meet the Commissions requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

2.2 EUT Exercise

The EUT (Transmitter) was tested with a test program to fix the TX/RX frequency that was for the purpose of the measurements. For more information please see test data and APPENDIX 1 for set-up photographs.

2.3 Measurement Equipment Used:

Equipment Name	Brand	Model	S/N	Last Cal. Date	Next Cal. Date
Magnetic Field probe	WAVECONTROL	SMP2	20SN1339	02/09/2022	08/09/2023

2.4 Configuration of Tested System

Radiated Emission

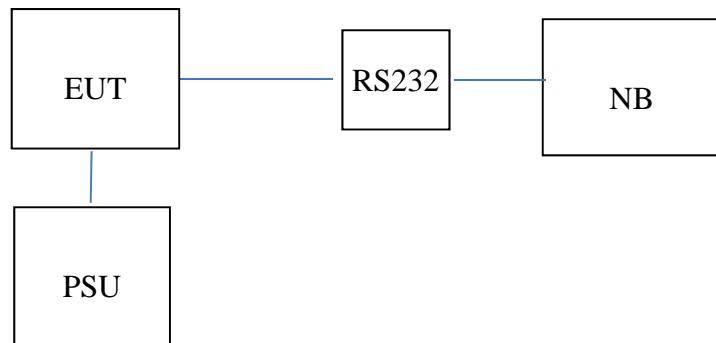


Table 1 Equipment Used in Tested System

Item	Equipment	Mfr/Brand	Model/ Type No.	Series No.	Data Cable	Power Cord
1	NB	Dell	X02-00	20201014 10193	15cm	N/A
2	PSU	ABM	8185D	N/A	N/A	30cm
3	RS232	ATEN	UC-232A	Z3F7- 076BP- 1698	185	N/A

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

2.5 Description of Test Modes

Test program used to control the EUT for staying in continuous transmitting and receiving mode is programmed.

Channel 134kHz with each modulation were chosen for full testing.

Maximum Permissible Exposure (MPE)

2.6 Test Procedure

2.6.1 Radiated Emissions

The EUT is placed on a turn table which is 0.8 m above ground plane. The Probe shall place near EUT 10cm, Test Six Plane to measure the position of maximum emission level.

3. Summary of Test Results

FCC Rules	Description Of Test	Result
§1.1310 (IEEE Std C95.1-2019)	Radiofrequency radiation exposure limits.	Compliant

4. Standard Applicable

According to §1.1310, Cause by EUT working frequency below 300KHz , The part MPE exposure limits refer ANSI in Section 4.1 of “IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz,” ANSI/IEEE Std C95.1, systems operating under the provisions of this section shall be operated in a manner that ensure that the public is not exposed to radio frequency energy level in excess of the Commission’s guideline.

Limits for Maximum Permissive Exposure (MPE)

Frequency Range (MHz)	Electric Field Strength (V/m)	Magnetic Field Strength (A/m)	Power Density (mW/cm ²)	Averaging Time (minute)
Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*(100)	30
1.34-30	824/f	2.19/f	*(180/f ²)	30
30-300	27.5	0.073	0.2	30
300-1500	/	/	F/1500	30
1500-15000	/	/	1.0	30

F = frequency in MHz

* = Plane-wave equipment power density

IEEE Std C95.1-2019

ERLs for whole-body exposure of persons in unrestricted environments (100 kHz to 300 GHz)
 [see Figure 3 for graphical representation]

Frequency Range	Electric field strength (E)a,b,c (V/m)	Magnetic field strength (H)a,b,c (A/m)	Power density (S) a,b,c (W/m ²)		Averaging Time (minute)
			SE	SH	
Limits for General Population/Uncontrolled Exposure					
0.1-1.34	614	16.3 / f_M	1000	$10000/f_M^2$	30
1.34-30	$823.8 / f_M$	$16.3 / f_M$	$1800/f_M^2$	$10000/f_M^2$	30
30-100	27.5	$158.3 / f_M^{1.668}$	2	$9400000/f_M^{3.336}$	30
100-400	27.5	0.07279		2	30
400-2000	/	/		$f_M/200$	30
2000-300000	/	/		10	30
NOTE—SE and SH are plane-wave-equivalent power density values, based on electric or magnetic field strength respectively, and are commonly used as a convenient comparison with ERLs at higher frequencies and are sometimes displayed on commonly used instruments					

1. For exposures that are uniform over the dimensions of the body, such as certain far-field plane-wave exposures, the exposure field strengths and power densities are compared with the ERLs in Table 7. For more typical nonuniform exposures, the mean values of the exposure fields, as obtained by spatially averaging the plane-wave-equivalent power densities or the squares of the field strengths, are compared with the ERLs in Table 7. (See notes to Table 7 through Table 11 in 4.3.5.)
2. f_M is the frequency in MHz.
3. The E, H, and S values are those rms values unperturbed by the presence of the body

5. Evaluation Result:

Test side	Distance to DUT (cm)	Frequency (MHz)	Measured E-Field (V/m)	Limit (V/m)
Front	10	0.134	45	614
Back	10	0.134	48	614
Left	10	0.134	35	614
Right	10	0.134	37	614
Upper	10	0.134	40	614
Bottom	10	0.134	46	614

Test side	Distance to DUT (cm)	Frequency (MHz)	Measured H-Field (A/m)	Limit (A/m)
Front	10	0.134	0.58	121.6
Back	10	0.134	0.57	121.6
Left	10	0.134	0.66	121.6
Right	10	0.134	0.68	121.6
Upper	10	0.134	0.65	121.6
Bottom	10	0.134	0.64	121.6

APPENDIX 1

PHOTOGRAPHS OF SET UP

Test Set up Photos

